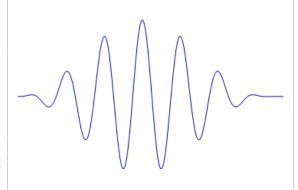
# **TBM - Tone Burst Measurement**

Software of the KLIPPEL R&D and QC SYSTEM (Document Revision 1.10)

#### **FEATURES**

- Maximum short-term SPL (ANSI/CEA)
- Harmonic distortion versus frequency and amplitude
- Sinusoidal transient stimulus (cycles, band-width)
- Complex compensation of sound reflections in non-anechoic environment (room)



#### **DESCRIPTION**

The TBM Module uses a transient sinusoidal burst to measure the peak SPL and harmonic distortion versus frequency and amplitude according to Standard ANSI/CEA-2010 and ANSI/CEA-2034. If the distortion exceeds a user defined threshold, the input amplitude will be not increased to prevent a damage of the device under test. A second state variable (displacement, voltage, current) can be measured simultaneously. Acoustical measurements can be performed in a non-anechoic environment by compensating the room reflections by inverse filtering of the microphone signal.

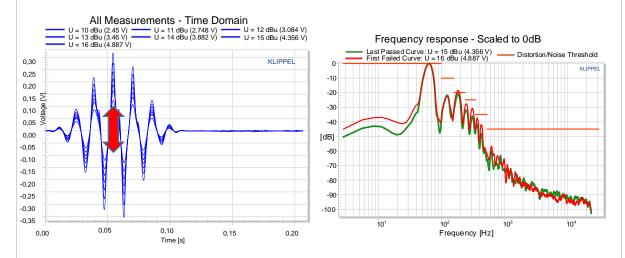
Article number 1001-109

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### 1 Principle

The Burst measurement module is designed to run band limited burst measurements versus input voltage and frequency. The results are evaluated in frequency domain, to measure the generated distortion. A threshold curve is applied to the  $1/12^{th}$  octave band smoothed spectrum, to define a maximum permissible distortion generation.



For each Frequency, the voltage is increased until the threshold curve is reached. The highest voltage not reaching the threshold curve is used to calculate the peak level of this state signal (Peak SPL in CEA2010) In parallel it is possible to monitor a second state signal, to investigate the displacement or current state signal.

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## 2 Excitation Signal (Stimulus)

Stimulus

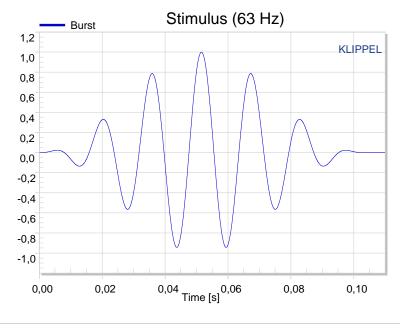
A 1/3 octave band-limited tone-burst signal centered to  $f_{\circ}$  is used:

$$f(t) = \begin{cases} \left(1 - \cos\frac{2\pi f_0 t}{6.5}\right) \frac{\sin 2\pi f_0 t}{2} & \text{for } 0 \le t \le \frac{6.5}{f_0} \end{cases}$$

t = time [sec]

 $f_{\circ}$  = center frequeny of the burst [Hz]

The following picture shows a normalized example test signal burst for  $f_{\circ}=63Hz$ .

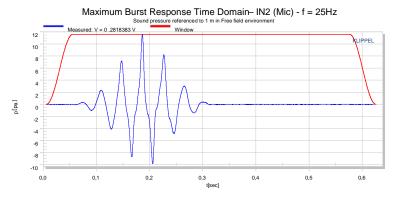


#### 3 **Post-processing**

TBM - Tone Burst Measurement

#### Windowing

The signal measured will be windowed to remove noise and unwanted room reflections. As defined in the standard CEA2010-B, the window length is twice the length of the test signal itself.



#### **Band-pass** filtering and peak SPL

The definition of the peak SPL measure by ANSI/CEA-2010-B standard remains with some ambiguity. This measurement module is kept as transparent as possible, to allow reproducible burst measurements.

The CEA2010-B standard states:

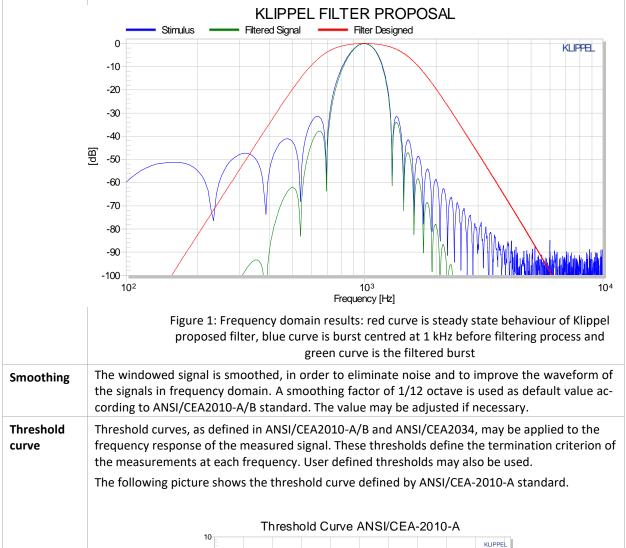
The peak SPL of the fundamental shall then be recorded. That is, the peak SPL is the highest peak sound pressure within 1/3 octave of the tone-burst stimulus fundamental frequency range

This statement is interpreted with the following filtering and peak SPL calculation:

Band-pass Filtering			
$h_{\mathit{BP}}(t)$ Butterworth zero phase 4th order Bandpass			
p(t) Sound pressure signal vs. time			
$p_{BP}(t) = p(t) * h_{BP}(t)$			
Filter type	Butterworth, zero phase		
Filter order	16 <sup>th</sup> order		
Filter bandwidth	6/5 <sup>th</sup> octave		

Peak SPL 
$$SPL_{peak} = 20*log\left(\frac{\max{(|p_{BP}(t)|)}}{p_{ref}}\right)$$
 
$$p_{ref} = 20\mu Pa$$

The following picture shows the wave shape of the filter and the signal before and after the filtering process.



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# 4 Requirements

#### 4.1 Hardware

Analyzer		The Distortion Analyzer or the Klippel Analyzer 3 are used as the hardware to perform the measurement.		
Microphone	[optional] Free field microphone with omnidirectional directivity characteristic over the desired measurement bandwidth.			
Amplifier	[optional] KA3 Amp-Card or external audio amplifier with a flat frequency response over the desired measurement bandwidth			
Laser Dis- placement Sensor	[optional] A high precision laser displacement sensor may be used to capture the membrane movement.			
Computer	Computer A personal computer is required for performing the measurement.			

#### 4.2 Software

dB-Lab Project Management Software of the KLIPPEL R&D SYSTEM. Requires at least version 210.450.

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5 Inputs				
Measurement Setup - Ro	uting			
Output at:	Point where the voltage defined will be applied to the system. Possible values:  OUT1 - OUT2  Speaker 1 terminals (via OUT1) - Speaker 1 terminals (via OUT2)  Speaker 2 terminals (via OUT1) - Speaker 2 terminals (via OUT2)  Default: Speaker 1 terminals (via OUT1)			
Input Signal Y1	State signal which will be analyzed, und whose results will be compared with threshold. Possible values:  - IN1 (Mic) - IN2 (Mic)  - Voltage Speaker 1 - Voltage Speaker 2  - Current Speaker 1 - Current Speaker 2  - Displacement  Default: IN1 (Mic)			
Input Signal Y2	State signal which will be measured simultaneously with state signal 1. Possible values:  - Off - IN1 (Mic) - IN2 (Mic) - Voltage Speaker 1 - Voltage Speaker 2 - Current Speaker 1 - Current Speaker 2 - Displacement  Default: Off			
Apply Room Correction Curve	For measurements in non-anechoic environment or small anechoic chambers a correction curve should be used to compensate the room influence. The flag activates the compensation.			
Measurement Setup – IN	1 (Mic) (same for IN2 (Mic))			
IN1 Meas. Distance [m]	Measurement distance between microphone and DUT in meter.  Default: 1m			
IN1 Environment	Measurement environment of microphone. Possible values:  - Full space (4 pi)  - Half space (2 pi)  Default: Full space (4 pi)			
IN1 Microphone Sensitivity	Microphone sensitivity defined in mV / Pa  Default: 50mV / Pa			
IN1 (Mic) Room Correction Curve	Correction filter to compensate the room influence for In-Situ measurements.			
IN1 (Mic) Microphone Correction Curve	Microphone calibration curve.			
Stimulus				
Voltage Range Definition	Measurement voltages can be defined according three different modes:  - Fix Step size: voltage raises according a fix step size  - Single Voltage: a single voltage is measured per frequency  - User Defined: User defines voltages to be measured at each frequency  Default: Fix Step Size			

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Max. Voltage	Highest voltage allowed in V. If the threshold is reached before, this voltage will not be measured. This parameter is only available if <i>Voltage Range Definition</i> is <i>Fix Step Size</i> .  Default: 5V			
Neglect threshold be- low [Vp]	Voltage the measurement is continued up to, even if a measurement is failed. This parameter is only available if <i>Voltage Range Definition</i> is <i>Fix Step Size</i> .  Default: 2V			
Start Voltage [Vp]	Lowest voltage at the input of DUT in V. The measurement starts at this value. This parameter is only available if <i>Voltage Range Definition</i> is <i>Fix Step Size</i> .  Default: 1V			
Voltage Step Size [dB]	Step size of the voltage increment in dB. This parameter is only available if <i>Voltage</i> Range Definition is Fix Step Size.  Default: 1dB			
Voltage	Single voltage measured per frequency. This parameter is only available if <i>Voltage</i> Range Definition is Single voltage.  Default: 1V			
Voltage Profile	Voltages to be measured at each frequency. This parameter is only available if Voltage Range Definition is User Defined.			
Fundamental Freq. [Hz]	Vector of frequencies to be analysed in Hz. This Input can be overwritten through Calculate Fundamental Freq. parameter.  Default: [20, 25, 32, 40, 50, 63, 80, 100, 125, 160] (ANSI/CEA-2010-B)			
Burst periods	Periods of fundamental tone in burst (stimulus signal).  Default: 6.5			
Preloop [#]	Amount of signal loops to be run before the measurement is recorded Default: 0			
Averaging [#]	Number of measurements to average results. Possible values:  - 1			
Pause	Between the measurements, the process can be paused using this parameter.			
Processing				
Smoothing bandwidth	Smoothing Bandwidth for results in frequency domain.  Default: 12 (1/12 octave)			
Activate Threshold	This parameter activates the use of the threshold in the measurements.			

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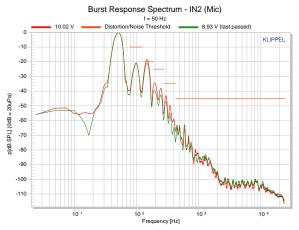
Threshold curves	Threshold to be compared with the frequency response of the measurements. It is defined by several fields:  - freqLimits: 2x1 vector which defines frequency range where threshold is applied: [f <sub>LOW</sub> f <sub>HIGH</sub> ]  - freq1 − freq5: Define ranges of fundamental frequencies to applied thres1  - thres5. They are defined as a 2x1 vector: [f <sub>LOW</sub> f <sub>HIGH</sub> ] where f <sub>LOW</sub> ≤ f <sub>RANGE</sub> < f <sub>HIGH</sub> .  - thres1 − thres5: Relative frequencies and amplitudes of the threshold curve saved in a matrix [3xN] First and second columns are minimum and maximum relative freq to apply threshold step. Third column is value of threshold in dB referenced to the peak value of the fundamental frequency.  Default: ANSI/CEA-2010-B threshold curve
Display	
Update Result Windows	To monitor the measurement process the result windows can be updated. The Parameter defines how often the windows are recalculated. The curves can be updated after each burst, only after failed measurements or once at the end.
Confirm Measurements	To get more process control over burst measurement the parameter confirm measurements can activate more user interaction. If it desired the TBM module will ask after every measurement or after all failed measurement how to continue. Thus the user has full control to continue with the next burst or repeat the last measurement.
Frequency [Hz]	Center frequency of shown results.  Default: first measurement frequency
Voltage [V]	Voltage value of measurement to be plotted in windows Spectrum and Time Signal. If it disabled, default value is plotted. Possible values:  - Max Voltage - Voltages measured at Frequency  Default: Max Voltage
Peak Value	Visualization of plots Y1 Peak Value (u, f) and Y2 Peak Value (u, f).  - dB SPL vs Freq  - dB SPL vs Voltage  Default: dB SPL vs Voltage
Distortion	Data domain used in charts <i>Total Burst Distortion</i> , <i>2nd Order Burst Distortion</i> and <i>3rd Order Burst Distortion</i> of signals Y1 and Y2. Possible values:  - Percentage - dB  Default: Percentage
Results reference distance	Reference distance between microphone and DUT, in which the results are shown Default: 1m
Results Environment	Results referenced environment, in which the results are shown. Possible values:  - Full space (4 pi)  - Half space (2 pi)  Default: Full space (4 pi)

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#### **6 Result Windows**

#### Y1(f) Spectrum

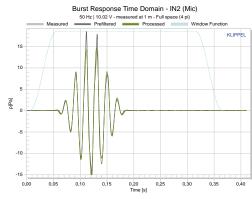
Graph showing the last passed and the first failed measurement of input signal Y1 in frequency domain with the defined threshold curve at the selected frequency. If Voltage parameter is activated, measurement at selected voltage is shown.



#### Y1(t) Time Signal

Graph showing the recorded, gated and filtered signal of the last passed measurement of input signal Y1 in time domain.

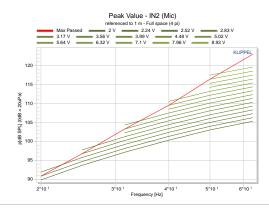
From last passed measurement signal Y1\_peak is determined.



#### Y1/Y2 Peak Value

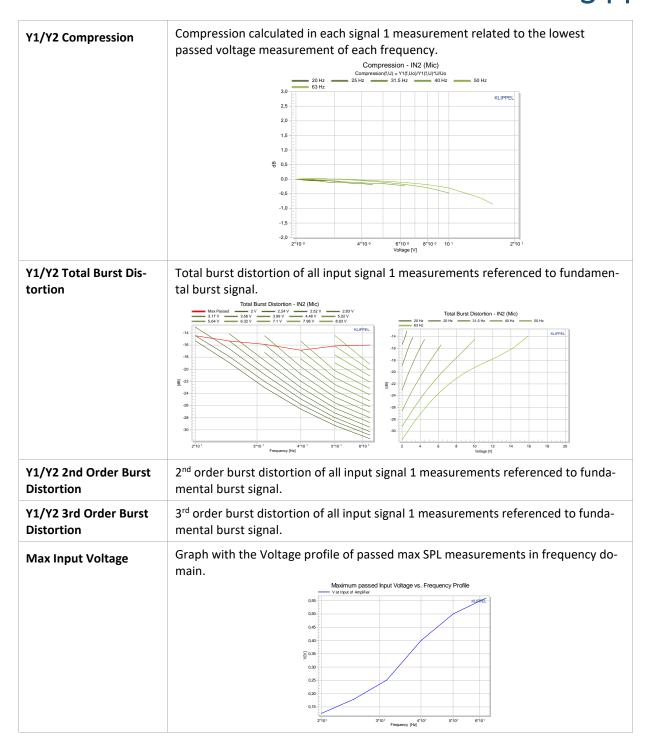
 $Y_{\text{PEAK}}$ : Peak value of input signal 1 versus voltage and frequency, in dB.

 $Y_{\text{PEAK},\text{MAX}}(f)$ : Profile of maximal peak SPL value of input signal 1 in frequency domain.



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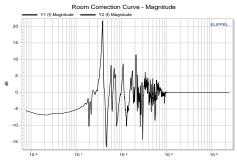
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#### **Correction Curve**

For measurements in small anechoic chambers or non-anechoic rooms it is required to use correction filter that compensates the room influence. The magnitude of this room correction filter as well as the microphone correction curve are shown in the window.



#### **Table Results + Settings**

Shows warnings and errors produced during the process, data collection table of results, measurement conditions and settings of measurement.

#### **Data Collection Table**

Tone Burst Center Frequency (Hz)	Maximum SPL	ANSI/CEA2010- A Rating		
20	103.88			
25	109.54	110.65		
31.5	115.05			
40	121.58	125.41		
50	125.41			
63	128.06			
Sound pressure referenced to 1 m in Half space (2 pi) environment				

#### Measurements conditions:

State Signal	Measurement Distance	Environment	L <sub>MEAS</sub> - L <sub>REF</sub>
IN2 (Mic 2)	1 m	Full space (4 pi)	6.02 dB

#### Settings and Signal properties:

Parameter	Value	Unit	Description
S <sub>MIC 2</sub>	33.6	mV/Pa	Sensitivity Microphone IN2
Preloops	0	-	Signal loops before measurement
Average	1	-	Loops measured and averaged
Periods of tone	6.5	-	Periods of tone in burst signal
f <sub>s</sub>	48000	Hz	Sample Rate
Order of Filter	4	-	Order of band-pass filter
Bandwidth of Filter	1/3	oct.	Bandwidth of band-pass filter related to central frequency
Smoothing	1/12	oct.	Frequency response smoothing value
T <sub>Burst</sub>	.325	s	Length of tone burst

#### **Table Peak SPL**

Shows a summary with the entire peak SPL values obtained in each measurement.

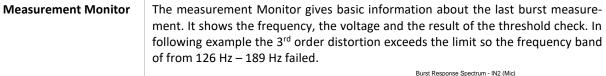
#### Peak Values - IN2 (Mic)

referenced to 1 m - Full space (4 pi)

	20 Hz	25 Hz	31.5 Hz	40 Hz	50 Hz	63 Hz
20 V	-	-	-	-	-	-
17.83 V	-	-	-	-	-	-
15.89 V	-	-	-	-	-	124.16 dB
14.16 V	-	-	-	-	-	122.96 dB
12.62 V	-	-	-	-	-	121.83 dB
11.25 V	-	-	-	-	-	120.72 dB
10.02 V	-	-	-	-	117.51 dB	119.6 dB
8.93 V	-	-	-	-	116.42 dB	118.54 dB
7.96 V	-	-	-	-	115.33 dB	117.49 dB
7.1 V	-	-	-	-	114.28 dB	116.45 dB
6.32 V	-	-	-	110.57 dB	113.22 dB	115.41 dB
5.64 V	-	-	-	109.54 dB	112.19 dB	114.4 dB
5.02 V	-	-	-	108.49 dB	111.14 dB	113.36 dB
4.48 V	-	-	104.34 dB	107.5 dB	110.12 dB	112.35 dB
3.99 V	-	-	103.3 dB	106.47 dB	109.09 dB	111.33 dB
3.56 V	-	-	102.29 dB	105.46 dB	108.07 dB	110.32 dB
3.17 V	-	97.78 dB	101.25 dB	104.43 dB	107.04 dB	109.31 dB
2.83 V	-	96.78 dB	100.27 dB	103.42 dB	106.05 dB	108.32 dB
2.52 V	91.92 dB	95.77 dB	99.22 dB	102.39 dB	105.01 dB	107.31 dB
2.24 V	90.88 dB	94.7 dB	98.18 dB	101.34 dB	104 dB	106.28 dB
2 V	89.87 dB	93.72 dB	97.15 dB	100.35 dB	103.04 dB	105.3 dB

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7	References		
7.1 Related Modules Live Audio Analyzer (LAA)  Distortion Measurement (DIS)			
		<u>Transfer Function Measurement</u> (TRF)	
		Multi-Tone Measurement (MTON)	
		In-Situ Room Compensation (ISC)	
7.2	Manuals	Tone Burst Measurement Manual	
7.3	Standards	ANSI/CEA-2010-A: "Standard Method of Measurement for Powered Subwoofers", 2012, Consumer Electronics Association	
		ANSI/CEA-2010-B: "Standard Method of Measurement for Subwoofers", 2014, Consumer Electronics Association	
		ANSI/CEA-2034: "Standard Method of Measurement for In-Home Loudspeakers", 2013, Consumer Electronics Association	

Find explanations for symbols at:

TBM - Tone Burst Measurement

http://www.klippel.de/know-how/literature.html

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